

REMARKS

Claims 1, 3, 4, 6, 8, 9, 11, 12, 14, 16, 17, 19, 20, 22 and 24 are currently pending in the application.

This amendment is in response to the Advisory Action of June 27, 2006.

Information Disclosure Statement(s)

Applicants note the filing of an Information Disclosure Statement herein on August 25, 2006, and note that a copy of the PTO/SB/08 was not returned with the outstanding Office Action. Applicants have enclosed a second copy of the PTO/SB/08 with this Amendment Accompanying Request for Continued Examination, as well as a copy of the return date-stamped postcard, and respectfully request that a signed copy of the PTO/SB/08 be returned to Applicants' counsel, and that the information cited on the PTO/SB/08 be made of record herein.

35 U.S.C. § 112 Claim Rejections

Claims 6 and 14 are rejected under 35 U.S.C. § 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which Applicants regard as the invention.

Applicants have amended the claimed invention to particularly point out and distinctly claim the subject matter of the invention to comply with the provisions of 35 U.S.C. § 112, second paragraph. Therefore, presently amended claims 6 and 14 are allowable under the provisions of 35 U.S.C. § 112.

35 U.S.C. § 103(a) Obviousness Rejections

Obviousness Rejection Based on Weng et al. (U.S. Patent 5,972,234) in View of Ishiwata et al. (U.S. Patent 5,300,172)

Claims 1, 3, 4, 6, 8, 9, 11, 12, 14, 16, 17, 19, 20, 22, and 24 are rejected under 35 U.S.C. § 103(a) as being unpatentable over Weng et al. (U.S. Patent 5,972,234) in view of Ishiwata et al. (U.S. Patent 5,300,172). Applicants respectfully traverse this rejection, as hereinafter set forth.

Applicants assert that to establish a *prima facie* case of obviousness under 35 U.S.C. § 103 three basic criteria must be met. First, there must be some suggestion or motivation, either in the references themselves or in the knowledge generally available to one of ordinary skill in the art, to modify the reference or to combine reference teachings. Second, there must be a reasonable expectation of success. Third, the cited prior art reference must teach or suggest all of the claim limitations. Furthermore, the suggestion to make the claimed combination and the reasonable expectation of success must both be found in the prior art, and not based on Applicants' disclosure.

After carefully considering the cited prior art, the rejections, and the Examiner's comments, Applicants have amended the claimed invention to clearly distinguish over the cited prior art.

Applicants assert that the amendments to the claims are clearly supported by the specification in at least specification paragraphs numbered [0039] through [0041], [0044], and [0048] through [0051] and clearly comply with the provisions of 35 U.S.C. § 132.

Turning to the cited prior art, Weng et al. teaches or suggests a method for marking a semiconductor surface. Weng et al. describe a polymeric tape can be provided that is suitable for ablative photodecomposition. Column 4 lines 25-40. In other words, the mark which is to be formed in the semiconductor surface is first formed as a cavity through the tape using "high-intensity energy beams such as ultraviolet light or laser." Column 4 lines 32-33; *See also* column 2 lines 63-63, column 3 lines 6-11, column 3 lines 22-23, column 3 lines 27-30, column 3 lines 39-40, column 4 lines 52-54. After the mark has been formed *through* the tape, the tape is applied to the semiconductor surface. Column 4 line 57 – column 5 line 7. Finally, the mark is formed in the semiconductor surface by etching the semiconductor in the area exposed by the mark formed in the tape. The tape protects the rest of the semiconductor surface from the etchant, such that the mark in the tape is patterned into the semiconductor surface. Column 5 lines 8-25. Finally, the tape is removed from the surface of the semiconductor, leaving the mark formed by the etchant. Column 5 lines 27 – 37. The tape has a thickness of about 0.5 mm and can be provided with an adhesive backing or without an adhesive backing. Column 5, lines 38-41. A suitable adhesive may be an acrylic type polymer. Column 4, lines 63,64.

The Ishiwata et al. reference teaches or suggests the use of a radiation curable adhesive tape on a wafer to form at three dimensional network.

Applicants assert that any combination of the Weng et al. reference in view of the Ishiwata et al. reference fails to establish a *prima facie* case of obviousness under 35 U.S.C. § 103 regarding the claimed inventions of presently amended independent claims 1, 9, and 17 because cited prior art fails to teach or suggest all the claim limitations and the suggestion to make the claimed combination and the reasonable expectation of success must be found solely in Applicants' disclosure, not the cited prior art.

Applicants assert that the cited prior art fails to teach or suggest the claim limitations of presently amended independent claims 1, 9, and 17 calling for "a tape comprising a flexible film material having a coefficient of thermal expansion substantially similar to the semiconductor device", "a flexible film material having a coefficient of thermal expansion substantially similar to the semiconductor device", "film material having a coefficient of thermal expansion substantially similar to the semiconductor device", "a first outermost adhesive layer comprising a mixture of electromagnetic radiation-curable components, the electromagnetic radiation-curable components providing a laser-markable surface upon exposure to an electromagnetic radiation source by curing and bonding to at least a portion of a semiconductor device when laser marking a semiconductor device" and "a second adhesive layer different than the first outermost adhesive layer disposed between the tape and the first outermost adhesive layer, the second adhesive layer comprising a mixture of electromagnetic radiation-curable components upon exposing to radiation the second adhesive layer performs at least one property of the adhesive facilitating peeling of the flexible film material when laser marking a semiconductor device". Applicants assert that, in contrast to the presently claimed inventions of presently amended independent claims 1, 9, and 17, the Weng et al. reference, at best, teaches or suggests a tape having one single adhesive layer, not a tape having multilayer adhesive while the Ishiwata et al. reference teaches or suggests the use of a radiation curable adhesive tape on a wafer to form at three dimensional network while any combination of the Weng et al. reference and the Ishiwata et al. reference teaches or suggests a tape having one adhesive layer used to form a three dimensional network. Further, Applicants assert that since Weng et al. does not teach or suggest using a tape that has laser markable surface and since Ishiwata et al. teach or suggest the use of a radiation

cured adhesive used to form a three dimensional network, any rejection based upon the Weng et al. reference and the Ishawa et al. reference is a hindsight reconstruction of the Applicants inventions based solely upon Applicants' disclosure because neither Weng et al. contains any such teaching or suggestion and Ishawa et al. merely forms three dimensional networks using adhesive. In each instance of the various embodiments of the Weng et al. reference, the semiconductor device is marked using an etchant, not a laser. In Ishawa et al. the adhesive is used to form only three dimensional networks. The claimed inventions of presently amended independent claims 1, 9, and 17 contain the claim limitations for a tape having at least two layers of different adhesive thereon. The first layer of adhesive contains the claim limitation calling for "comprising a mixture of electromagnetic radiation-curable components, the electromagnetic radiation-curable components providing a laser-markable surface upon exposure to an electromagnetic radiation source by curing and bonding to at least a portion of a semiconductor device". The second layer of adhesive contains the claim limitation calling for a different adhesive than the first outermost layer of adhesive comprising "a mixture of electromagnetic radiation-curable components to radiation the second adhesive layer performs at least one curing onto portions of the first outermost adhesive layer and losing adhesive properties for facilitating peeling of the flexible film material". The second layer of adhesive has different properties from the first layer of adhesive. The different properties of the first layer of adhesive and the second layer of adhesive are clearly distinct from each other as both described in the independent claims 1, 9, and 17 and in Applicants' disclosure. Such properties are set forth in the claimed inventions of presently amended independent claims 1, 9, and 17. In contrast to the claimed inventions, the Weng et al. reference merely teaches or suggests a single layer of adhesive.

Further, Applicants assert that to include radiation-curable components into any adhesive layer formed in the tape disclosed by Weng et al. would render the invention inoperable. Specifically, applying any energy would *cure* the adhesive layer, which would prevent a pattern from being formed through the tape. Therefore, no mark could be formed through the tape by any ablative photodecomposition process followed by the use of an etchant to form a mark on the semiconductor device if the adhesive layer of the tape were to include radiation-curable components. Applicants respectfully assert that a tape comprising an adhesive layer including radiation-curable components is not "any suitable tape of polymeric based material, which can be

easily patterned by high-intensity energy beams such as ultraviolet light or laser” or is not any single layer of adhesive containing “arbitrary or imaginary layers within a single layer”.

Additionally, Applicants assert that the Weng et al. reference merely describes a photodecomposition process employing an excimer type laser for ablating the polymeric based tape. The Weng et al. reference contains no description whatsoever as to how an excimer laser affects the adhesive. Applicants assert that absent any description as to how an excimer laser affects the adhesive used with the tape, any rejection based upon the Weng et al. reference is based solely upon Applicants’ disclosure, not the cited prior art.

Yet further, Applicants assert that the sole basis for any rejection under 35 U.S.C. § 103 based upon the cited combination of the prior art is solely Applicants’ disclosure. Applicants assert that such is clearly evident by the comments in the Office Action directed to the fact that nowhere in the Weng et al. reference is there any teaching or suggestion for multiple layers of adhesive. Solely the Applicants’ disclosure contains any such teaching or suggestion.

Applicants assert that such cited prior art does not and cannot establish a *prima facie* case of obviousness under 35 U.S.C. § 103 because such prior art fails to teach or suggest all the claim limitations and the suggestion to make the claimed combination and the reasonable expectation of success must be found solely in Applicants’ disclosure, not the cited prior art.

Accordingly, Applicants assert that claims 1, 3, 4, 6, 8, 9, 11, 12, 14, 16, 17, 19, 20, 22 and 24 are allowable.

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Applicants request the allowance of claims 1, 3, 4, 6, 8, 9, 11, 12, 14, 16, 17, 19, 20, 22 and 24 and the case passed for issue.

Respectfully submitted,



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Date: July 11, 2006

JRD/mah:lmh

Enclosures: Copy of PTO/SB/08 filed August 25, 2005
Copy of return date-stamped postcard
Check No. 9809 in the amount of \$790.00

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